

General Description

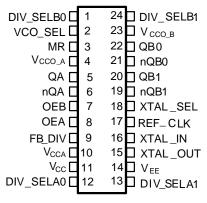
The 8433625 is a 3 differential output LVPECL Synthesizer designed to generate Ethernet reference clock frequencies. Using a 25MHz or 26.041666MHz, 18pF parallel resonant crystal, the following frequencies can be generated based on the settings of 4 frequency select pins (DIV_SELA[1:0], DIV_SELB[1:0]): 625MHz, 312.5MHz, 156.25MHz, and 125MHz. The 8433625 has 2 output banks, Bank A with 1 differential LVPECL output pair and Bank B with 2 differential LVPECL output pairs.

The two banks have their own dedicated frequency select pins and can be independently set for the frequencies mentioned above. The 8433625 uses IDT's 3rd generation low phase noise VCO technology and can achieve 1ps or lower typical rms phase jitter, easily meeting Ethernet jitter requirements. The 8433625 is packaged in a small 24-pin TSSOP package.

Features

- Three 3.3V LVPECL outputs on two banks, A Bank with one LVPECL pair and B Bank with 2 LVPECL output pairs
- Using a 25MHz or 26.041666 crystal, the two output banks can be independently set for 625MHz, 312.5MHz, 156.25MHz or 125MHz
- Selectable crystal oscillator interface or LVCMOS/LVTTL single-ended input
- VCO range: 520MHz 680MHz
- RMS phase jitter @ 156.25MHz (1.875MHz 20MHz): 0.3ps (typical)
- Full 3.3V supply mode
- 0°C to 70°C ambient operating temperature
- Available in lead-free (RoHS 6) package

Pin Assignment

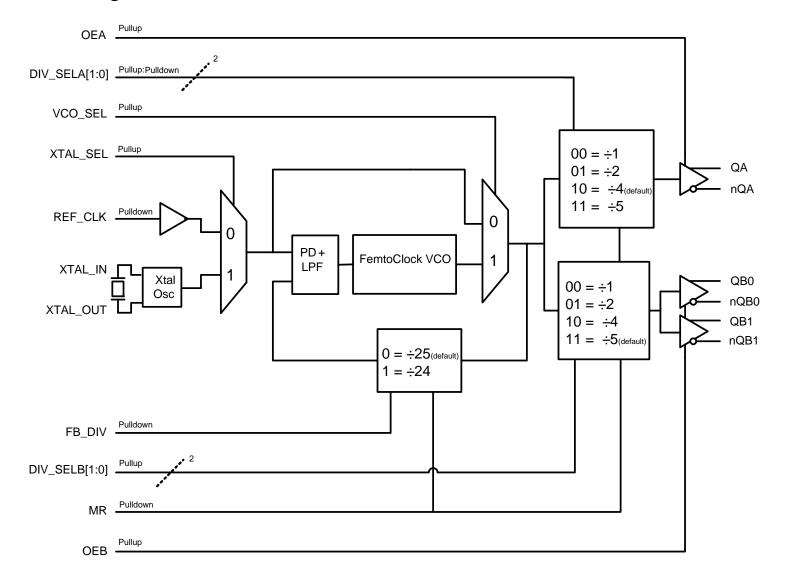


8433625

24-Lead TSSOP 4.4mm x 7.8mm x 0.925mm package body G Package Top View



Block Diagram





Pin Description and Pin Characteristic Tables

Table 1. Pin Descriptions

Number	Name	7	Туре	Description
1	DIV_SELB0	Input	Pullup	Division select pin for Bank B. Default = HIGH. LVCMOS/LVTTL interface levels.
2	VCO_SEL	Input	Pullup	VCO select pin. When Low, the PLL is bypassed and the crystal reference or REF_CLK (depending on XTAL_SEL setting) are passed directly to the output dividers. Has an internal pullup resistor so the PLL is not bypassed by default. LVCMOS/LVTTL interface levels.
3	MR	Input	Pulldown	Active HIGH Master Reset. When logic HIGH, the internal dividers are reset causing the true outputs Qx to go low and the inverted outputs nQx to go high. When logic LOW, the internal dividers and the outputs are enabled. Has an internal pulldown resistor so the power-up default state of outputs and dividers are enabled. LVCMOS/LVTTL interface levels.
4	V _{CCO_A}	Power		Output supply pin for Bank A outputs.
5, 6	QA, nQA	Output		Differential output pair. LVPECL interface levels.
7	OEB	Input	Pullup	Output enable Bank B. Active High output enable. When logic HIGH, the output pair on Bank B is enabled. When logic LOW, the output pair drives differential Low (QBx = Low, nQBx = High). Has an internal pullup resistor so the default power-up state of outputs are enabled. LVCMOS/LVTTL interface levels.
8	OEA	Input	Pullup	Output enable Bank A. Active High output enable. When logic HIGH, the output pair on Bank A is enabled. When logic LOW, the output pair drives differential Low (QA = Low, nQA = High). Has an internal pullup resistor so the default power-up state of outputs are enabled. LVCMOS/LVTTL interface levels.
9	FB_DIV	Input	Pulldown	Feedback divide select. When Low (default), the feedback divider is set for ÷25. When HIGH, the feedback divider is set for ÷24. LVCMOS/LVTTL interface levels.
10	V _{CCA}	Power		Analog supply pin.
11	V _{CC}	Power		Core supply pin.
12	DIV_SELA0	Input	Pulldown	Division select pin for Bank A. Default = LOW. LVCMOS/LVTTL interface levels.
13	DIV_SELA1	Input	Pullup	Division select pin for Bank A. Default = HIGH. LVCMOS/LVTTL interface levels.
14	V _{EE}	Power		Negative supply pin.
15, 16	XTAL_OUT, XTAL_IN	Input		Parallel resonant crystal interface. XTAL_OUT is the output, XTAL_IN is the input. XTAL_IN is also the overdrive pin if you want to overdrive the crystal circuit with a single-ended reference clock.
17	REF_CLK	Input	Pulldown	Single-ended reference clock input. Can leave floating if using the crystal interface. LVCMOS/LVTTL interface levels.
18	XTAL_SEL	Input	Pullup	Crystal select pin. Selects between the single-ended REF_CLK or crystal interface. Has an internal pullup resistor so the crystal interface is selected by default. LVCMOS/LVTTL interface levels.
19, 20	nQB1, QB1	Output		Differential output pair. LVPECL interface levels.
21, 22	nQB0, QB0	Output		Differential output pair. LVPECL interface levels.
23	V _{CCO_B}	Power		Output supply pin for Bank B outputs.
24	DIV_SELB1	Input	Pullup	Division select pin for Bank B. Default = HIGH. LVCMOS/LVTTL interface levels.

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.



Table 2. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance			4		pF
R _{PULLUP}	Input Pullup Resistor			51		kΩ
R _{PULLDOWN}	Input Pulldown Resistor			51		kΩ

Function Tables

Table 3A. Bank A and Bank B Frequency Table

Inputs					24/21	QA, nQA,	
Crystal Frequency (MHz)	DIV_SELA1, DIV_SELB1	DIV_SELA0, DIV_SELB0	FB_DIV	Feedback Divider	Bank A, Bank B Output Divider	M/N Multiplication Factor	QB[0:1], nQB[0:1] Output Frequency (MHz)
25	0	0	0	25	1	25	625
25	0	1	0	25	2	12.5	312.5
25	1	0	0	25	4	6.25	156.25
25	1	1	0	25	5	5	125
26.041666	0	0	1	24	1	24	625
26.041666	0	1	1	24	2	12	312.5
26.041666	1	0	1	24	4	6	156.25
26.041666	1	1	1	24	5	4.8	125

Table 3C. Output Bank Configuration Select Function Table

Inputs		Bank A	Inp	Bank B	
DIV_SELA1	DIV_SELA0	Output Divider	DIV_SELB1	DIV_SELB0	Output Divider
0	0	1	0	0	1
0	1	2	0	1	2
1	0	4 (default)	1	0	4
1	1	5	1	1	5 (default)

Table 3D. Feedback Divider Configuration Select Function Table

Inputs						
FB_DIV	Feedback Divide					
0	25 (default)					
1	24					



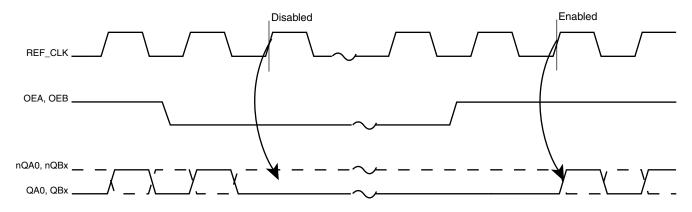


Figure 1. OE Timing Diagram

Absolute Maximum Ratings

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V _{CC}	4.6V
Inputs, V _I	-0.5V to V _{CC} + 0.5V
Outputs, I _O (LVPECL) Continuous Current Surge Current	50mA 100mA
Package Thermal Impedance, θ_{JA}	82.3°C/W (0 mps)
Storage Temperature, T _{STG}	-65°C to 150°C

DC Electrical Characteristics

Table 4A. Power Supply DC Characteristics, $V_{CC} = V_{CCO_A} = V_{CCO_B} = 3.3V \pm 0.3V$, $V_{EE} = 0V$, $T_A = 0$ °C to 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{CC}	Core Supply Voltage		3.0	3.3	3.6	V
V _{CCA}	Analog Supply Voltage		V _{CC} - 0.25	3.3	V _{CC}	V
V _{CCO_A} , V _{CCO_B}	Output Supply Voltage		3.0	3.3	3.6	V
I _{EE}	Power Supply Current				125	mA
I _{CCA}	Analog Supply Current				25	mA



Table 4B. LVCMOS/LVTTL DC Characteristics, $V_{CC} = V_{CCO_A} = V_{CCO_B} = 3.3V \pm 0.3V$, $V_{EE} = 0V$, $T_A = 0$ °C to 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V _{IH}	Input High Volta	age		2		V _{CC} + 0.3	V
V _{IL}	Input Low Volta	age		-0.3		0.8	V
I _{IH} Input High Cu	lanut	DIV_SELA0, REF_CLK, FB_DIV, MR	V _{CC} = V _{IN} = 3.6V			150	μΑ
	High Current	OEA, OEB, DIV_SELA1, DIV_SELB0, DIV_SELB1, VCO_SEL, XTAL_SEL	$V_{CC} = V_{IN} = 3.6V$			5	μΑ
	land	DIV_SELA0, REF_CLK, FB_DIV, MR	V _{CC} = 3.6V, V _{IN} = 0V	-5			μΑ
In	Input Low Current	OEA, OEB, DIV_SELA1, DIV_SELB0, DIV_SELB1, VCO_SEL, XTAL_SEL	V _{CC} = 3.6V, V _{IN} = 0V	-150			μΑ

Table 4C. LVPECL DC Characteristics, $V_{\rm CC}$ = $V_{\rm CCO_A}$ = $V_{\rm CCO_B}$ = 3.3V \pm 0.3V, $V_{\rm EE}$ = 0V, $T_{\rm A}$ = 0°C to 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{OH}	Output High Voltage; NOTE 1		V _{CCO} – 1.4		V _{CCO} - 0.9	V
V _{OL}	Output Low Voltage; NOTE 1		V _{CCO} - 2.0		V _{CCO} - 1.7	V
V _{SWING}	Peak-to-peak Output Voltage Swing		0.5		1.0	V

NOTE 1: Outputs termination with 50Ω to $\rm V_{CCO_A,\,_B}-2V.$

Table 5. Crystal Characteristics

Parameter		Test Conditions	Minimum	Typical	Maximum	Units
Mode of Oscillation			Fundamental			
	FB_DIV = ÷25		20.8	25	27.2	MHz
Frequency	FB_DIV = ÷24		21.6	26.0416	28.3	MHz
Equivalent Series Resistance (ESR)					50	Ω
Shunt Capacitance					7	pF

NOTE: Characterized using an 18pF parallel resonant crystal.



AC Electrical Characteristics

Table 6. AC Characteristics, V_{CC} = V_{CCO_A} = V_{CCO_B} = 3.3V ± 0.3V, V_{EE} = 0V, T_A = 0°C to 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
		DIV_SELx[1:0] = 00		625		MHz
£.	Out of English	DIV_SELx[1:0] = 01		312.5		MHz
f _{OUT}	Output Frequency	DIV_SELx[1:0] = 10		156.25		MHz
		DIV_SELx[1:0] = 11		125		MHz
tsk(b)	Bank Skew, NOTE 1				35	ps
	Output Skew; NOTE 2, 4	Outputs @ Same Frequency			100	ps
tsk(o)		Outputs @ Different Frequencies			130	ps
		625MHz, (1.875MHz – 20MHz)		0.30		ps
£;t/Ø)	RMS Phase Jitter, (Random);	312.5MHz, (1.875MHz – 20MHz)		0.12		ps
<i>t</i> jit(Ø)	NOTE 3	156.25MHz, (1.875MHz – 20MHz)		0.30		ps
		125MHz, (1.875MHz – 20MHz)		0.24		ps
t _R / t _F	Output Rise/Fall Time	20% to 80%	200		700	ps
ada	Output Duty Ovolo	DIV_SELx[1:0] = 00	40		60	%
odc	Output Duty Cycle	DIV_SELx[1:0] ≠ 00	45		55	%

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 1: Defined as skew within a bank of outputs at the same supply voltage and with equal load conditions.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions.

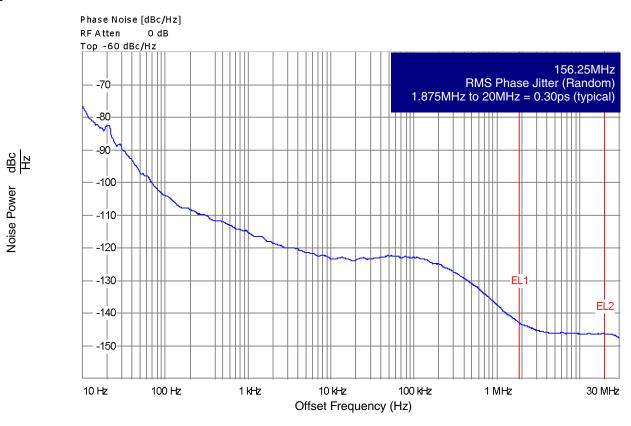
Measured at the output differential cross points.

NOTE 3: Please refer to the Phase Noise Plots.

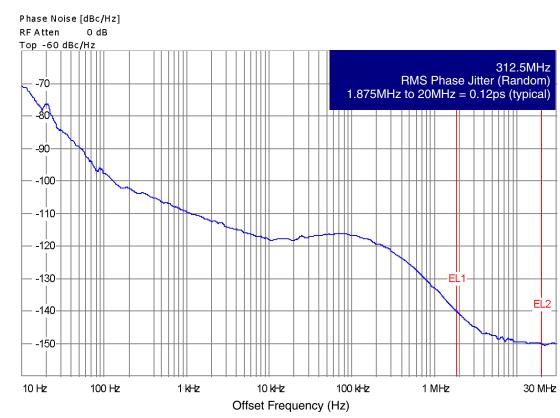
NOTE 4: This parameter is defined in accordance with JEDEC Standard 65.



Typical Phase Noise at 156.25MHz



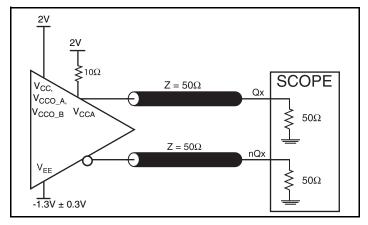
Typical Phase Noise at 312.5MHz



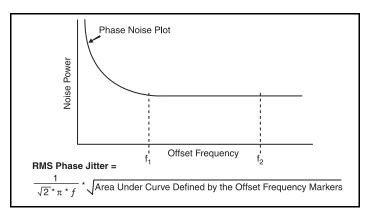
Noise Power dBc



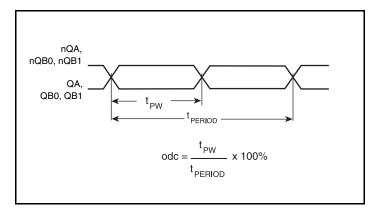
Parameter Measurement Information



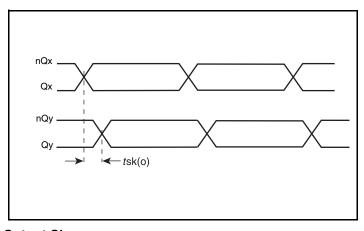
LVPECL Output Load AC Test Circuit



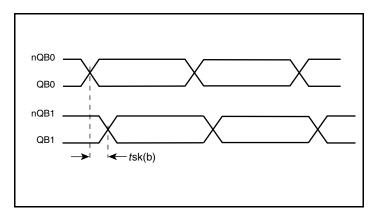
RMS Phase Jitter



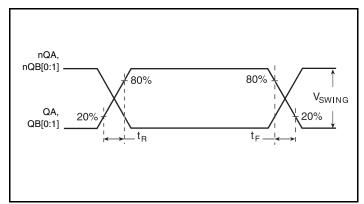
Output Duty Cycle/Pulse Width/Period



Output Skew



Bank Skew



Output Rise/Fall Time



Application Information

Power Supply Filtering Technique

As in any high speed analog circuitry, the power supply pins are vulnerable to random noise. To achieve optimum jitter performance, power supply isolation is required. The 8433625 provides separate power supplies to isolate any high switching noise from the outputs to the internal PLL. V_{CC_i} V_{CCA} and $V_{CCO_{_X}}$ should be individually connected to the power supply plane through vias, and $0.01\mu F$ bypass capacitors should be used for each pin. Figure 2 illustrates this for a generic V_{CC} pin and also shows that V_{CCA} requires that an additional 10Ω resistor along with a $10\mu F$ bypass capacitor be connected to the V_{CCA} pin.

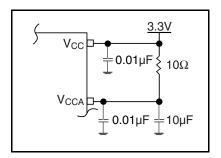


Figure 2. Power Supply Filtering

Recommendations for Unused Input and Output Pins

Inputs:

Crystal Inputs

For applications not requiring the use of the crystal oscillator input, both XTAL_IN and XTAL_OUT can be left floating. Though not required, but for additional protection, a $1 \, k\Omega$ resistor can be tied from XTAL_IN to ground.

REF CLK Input

For applications not requiring the use of the reference clock, it can be left floating. Though not required, but for additional protection, a $1k\Omega$ resistor can be tied from the REF CLK to ground.

LVCMOS Control Pins

All control pins have internal pullups or pulldowns; additional resistance is not required but can be added for additional protection. A $1k\Omega$ resistor can be used.

Outputs:

LVPECL Outputs

All unused LVPECL outputs can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.



Crystal Input Interface

The 8433625 has been characterized with 18pF parallel resonant crystals. The capacitor values shown in *Figure 3* below were

XTAL_IN

18pF Parallel Crystal

C1
27pF

XTAL_OUT

XTAL_OUT

Figure 3. Crystal Input Interface

determined using a 25MHz or 26.041666MHz 18pF parallel resonant crystal and were chosen to minimize the ppm error.

LVCMOS to XTAL Interface

The XTAL_IN input can accept a single-ended LVCMOS signal through an AC coupling capacitor. A general interface diagram is shown in *Figure 4*. The XTAL_OUT pin can be left floating. The input edge rate can be as slow as 10ns. For LVCMOS signals, it is recommended that the amplitude be reduced from full swing to half swing in order to prevent signal interference with the power rail and to reduce noise. This configuration requires that the output impedance of the driver (Ro) plus the series resistance (Rs) equals

the transmission line impedance. In addition, matched termination at the crystal input will attenuate the signal in half. This can be done in one of two ways. First, R1 and R2 in parallel should equal the transmission line impedance. For most 50Ω applications, R1 and R2 can be 100Ω . This can also be accomplished by removing R1 and making R2 50Ω . By overdriving the crystal oscillator, the device will be functional, but note, the device performance is guaranteed by using a quartz crystal.

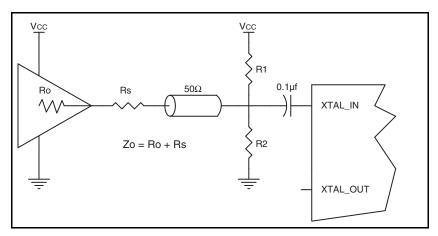


Figure 4. General Diagram for LVCMOS Driver to XTAL Input Interface



Termination for 3.3V LVPECL Outputs

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

The differential outputs are low impedance follower outputs that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are designed to drive 50Ω

 $Z_{o} = 50\Omega$ $Z_{o} = 50\Omega$ $RTT = \begin{bmatrix} 1 \\ \frac{1}{((V_{OH} + V_{OL}) / (V_{CC} - 2)) - 2} \\ & & \\ \end{bmatrix} * Z_{o}$ $RTT = \begin{bmatrix} 1 \\ \frac{1}{((V_{OH} + V_{OL}) / (V_{CC} - 2)) - 2} \\ & & \\ \end{bmatrix} * Z_{o}$

Figure 5A. 3.3V LVPECL Output Termination

transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. *Figures 5A and 5B* show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.

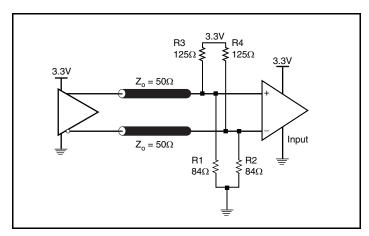


Figure 5B. 3.3V LVPECL Output Termination



Schematic Example

Figure 6 shows an example of 8433625 application schematic. In this example, the device is operated at $V_{CC} = V_{CCO_A} = V_{CCO_B} = 3.3V$. The 18pF parallel resonant 25MHz crystal is used. The C1 = 27pF and C2 = 27pF are recommended for frequency accuracy. for

different board layouts, the C1 and C2 may be slightly adjusted for optimizing frequency accuracy. Two examples of LVPECL terminations are shown in this schematic. Additional termination approaches are shown in the LVPECL Termination Application Note.

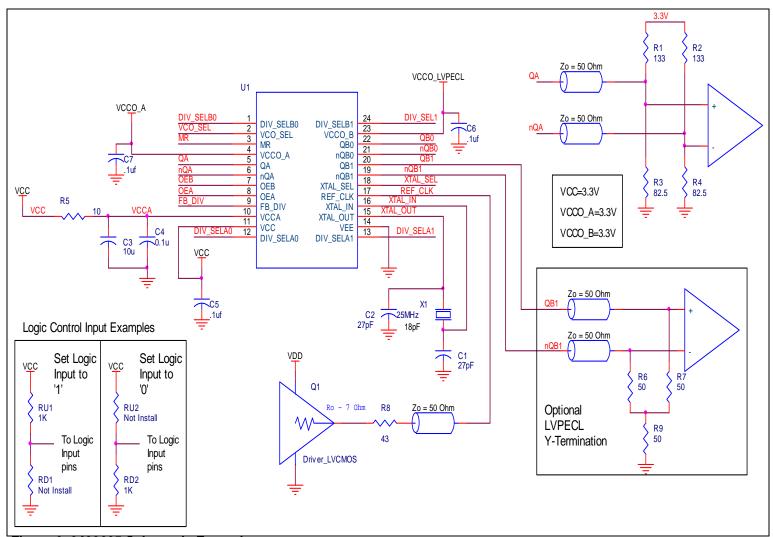


Figure 6. 8433625 Schematic Example



Power Considerations

This section provides information on power dissipation and junction temperature for the 8433625. Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the 8433625 is the sum of the core power plus the power dissipated in the load(s).

The following is the power dissipation for $V_{CC} = 3.3V + 0.3V = 3.6V$, which gives worst case results.

NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core)_{MAX} = V_{CC MAX} * I_{EE MAX} = 3.6V * 125mA = 450mW
- Power (outputs)_{MAX} = 30mW/Loaded Output pair
 If all outputs are loaded, the total power is 3 * 30mW = 90mW

Total Power_MAX (3.6V, with all outputs switching) = 450mW + 90mW = **540mW**

2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad and directly affects the reliability of the device. The maximum recommended junction temperature for devices is 125°C.

The equation for Tj is as follows: Tj = θ_{JA} * Pd_total + T_A

Tj = Junction Temperature

 θ_{JA} = Junction-to-Ambient Thermal Resistance

Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)

T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming no air flow and a multi-layer board, the appropriate value is 82.3°C/W per Table 7 below.

Therefore, Tj for an ambient temperature of 70°C with all outputs switching is:

 $70^{\circ}\text{C} + 0.540\text{W} * 82.3^{\circ}\text{C/W} = 114.4^{\circ}\text{C}$. This is well below the limit of 125°C .

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 7. Thermal Resistance θ_{JA} for 24 Lead TSSOP, Forced Convection

θ_{JA} by Velocity						
Meters per Second	0	1	2.5			
Multi-Layer PCB, JEDEC Standard Test Boards	82.3°C/W	78.0°C/W	75.9°C/W			



3. Calculations and Equations.

The purpose of this section is to derive the power dissipated into the load.

LVPECL output driver circuit and termination are shown in Figure 7.

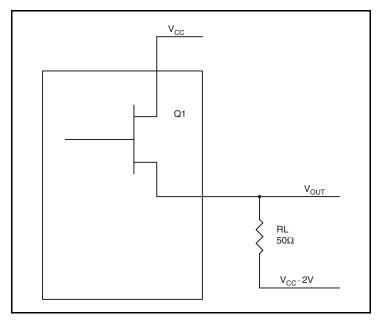


Figure 7. LVPECL Driver Circuit and Termination

To calculate worst case power dissipation into the load, use the following equations which assume a 50Ω load, and a termination voltage of $V_{CCO} - 2V$.

- For logic high, V_{OUT} = V_{OH_MAX} = V_{CCO_MAX} 0.9V
 (V_{CCO_MAX} V_{OH_MAX}) = 0.9V
- For logic low, V_{OUT} = V_{OL_MAX} = V_{CCO_MAX} 1.7V
 (V_{CCO_MAX} V_{OL_MAX}) = 1.7V

Pd_H is power dissipation when the output drives high.

Pd_L is the power dissipation when the output drives low.

$$Pd_H = [(V_{OH_MAX} - (V_{CCO_MAX} - 2V))/R_L] * (V_{CCO_MAX} - V_{OH_MAX}) = [(2V - (V_{CCO_MAX} - V_{OH_MAX}))/R_L] * (V_{CCO_MAX} - V_{OH_MAX}) = [(2V - 0.9V)/50\Omega] * 0.9V = 19.8mW$$

$$Pd_{L} = [(V_{OL_MAX} - (V_{CCO_MAX} - 2V))/R_{L}] * (V_{CCO_MAX} - V_{OL_MAX}) = [(2V - (V_{CCO_MAX} - V_{OL_MAX}))/R_{L}] * (V_{CCO_MAX} - V_{OL_MAX}) = [(2V - 1.7V)/50\Omega] * 1.7V = 10.2mW$$

Total Power Dissipation per output pair = Pd_H + Pd_L = 30mW



Reliability Information

Table 8. θ_{JA} vs. Air Flow Table for a 24 Lead TSSOP

$\theta_{\sf JA}$ vs. Air Flow					
Meters per Second	0	1	2.5		
Multi-Layer PCB, JEDEC Standard Test Boards	82.3°C/W	78.0°C/W	75.9°C/W		

Transistor Count

The transistor count for 8433625 is: 3076

Package Outline and Package Dimensions

Package Outline - G Suffix for 24 Lead TSSOP

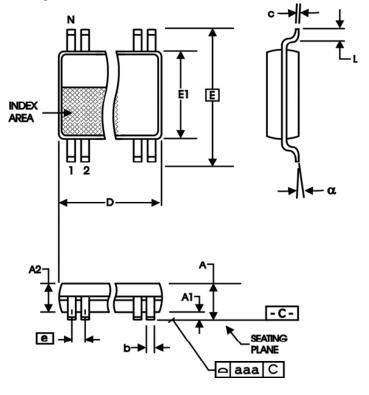


Table 9. Package Dimensions

All Dimensions in Millimeters					
Symbol	Minimum Maximum				
N	24				
Α		1.20			
A 1	0.5	0.15			
A2	0.80	1.05			
b	0.19	0.30			
С	0.09	0.20			
D	7.70	7.90			
Е	6.40 Basic				
E1	4.30	4.50			
е	0.65 Basic				
L	0.45	0.75			
α	0°	8°			
aaa		0.10			

Reference Document: JEDEC Publication 95, MO-153



Ordering Information

Table 10. Ordering Information

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
8433625AGLF	ICS8433625AGL	"Lead-Free" 24 Lead TSSOP	Tube	0°C to 70°C
8433625AGLFT	ICS8433625AGL	"Lead-Free" 24 Lead TSSOP	Tape & Reel	0°C to 70°C



Revision History Sheet

Rev	Table	Page	Description of Change	Date
		1	Section , "General Description" - deleted HiperClocks logo.	
	T10	17	Ordering Information Table - deleted Tape & Reel count.	
В			Deleted all HiperClocks references throughout the datasheet.	1/20/16
			Deleted ICS prefix from part number throughout the datasheet.	
			Updated datasheet header/footer.	



IMPORTANT NOTICE AND DISCLAIMER

RENESAS ELECTRONICS CORPORATION AND ITS SUBSIDIARIES ("RENESAS") PROVIDES TECHNICAL SPECIFICATIONS AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS OR IMPLIED, INCLUDING, WITHOUT LIMITATION, ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, OR NON-INFRINGEMENT OF THIRD-PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for developers who are designing with Renesas products. You are solely responsible for (1) selecting the appropriate products for your application, (2) designing, validating, and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. Renesas grants you permission to use these resources only to develop an application that uses Renesas products. Other reproduction or use of these resources is strictly prohibited. No license is granted to any other Renesas intellectual property or to any third-party intellectual property. Renesas disclaims responsibility for, and you will fully indemnify Renesas and its representatives against, any claims, damages, costs, losses, or liabilities arising from your use of these resources. Renesas' products are provided only subject to Renesas' Terms and Conditions of Sale or other applicable terms agreed to in writing. No use of any Renesas resources expands or otherwise alters any applicable warranties or warranty disclaimers for these products.

(Disclaimer Rev.1.01)

Corporate Headquarters

TOYOSU FORESIA, 3-2-24 Toyosu, Koto-ku, Tokyo 135-0061, Japan www.renesas.com

Trademarks

Renesas and the Renesas logo are trademarks of Renesas Electronics Corporation. All trademarks and registered trademarks are the property of their respective owners.

Contact Information

For further information on a product, technology, the most up-to-date version of a document, or your nearest sales office, please visit www.renesas.com/contact-us/.